## **Sensitive Gate Silicon Controlled Rectifiers**

## **Reverse Blocking Thyristors**

PNPN devices designed for high volume, line-powered consumer applications such as relay and lamp drivers, small motor controls, gate drivers for larger thyristors, and sensing and detection circuits. Supplied in an inexpensive plastic TO-226AA package which is readily adaptable for use in automatic insertion equipment.

#### Features

- Sensitive Gate Allows Triggering by Microcontrollers and Other Logic Circuits
- Blocking Voltage to 600 V
- On-State Current Rating of 0.8 A RMS at 80°C
- High Surge Current Capability 10 A
- Minimum and Maximum Values of IGT, VGT and IH Specified for Ease of Design
- Immunity to dV/dt 20 V/µsec Minimum at 110°C
- Glass-Passivated Surface for Reliability and Uniformity
- Pb-Free Packages are Available\*

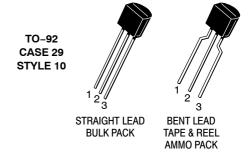


## **ON Semiconductor®**

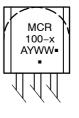
http://onsemi.com

**SCRs** 0.8 A RMS 100 thru 600 V





### MARKING DIAGRAM



= Specific Device Code А

= Assembly Location

Υ = Year

х

= Work Week ww

(Note: Microdot may be in either location)

PIN ASSIGNMENT		
1	Cathode	
2	Gate	
3	Anode	

#### **ORDERING INFORMATION**

See detailed ordering and shipping information on page 5 of this data sheet.

\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

<sup>=</sup> Pb-Free Package

#### MAXIMUM RATINGS (T<sub>J</sub> = 25°C unless otherwise noted)

Rating	Symbol	Value	Unit
Peak Repetitive Off–State Voltage (Notes 1 and 2) ( $T_J$ = -40 to 110°C, Sine Wave, 50 to 60 Hz; $R_{GK}$ = 1 k $\Omega$ ) MCR100–3 MCR100–4 MCR100–6 MCR100–8	V <sub>DRM,</sub> V <sub>RRM</sub>	100 200 400 600	V
On-State RMS Current, (T <sub>C</sub> = 80°C) 180° Conduction Angles	I <sub>T(RMS)</sub>	0.8	А
Peak Non-Repetitive Surge Current, (1/2 Cycle, Sine Wave, 60 Hz, $T_J$ = 25°C)	I <sub>TSM</sub>	10	А
Circuit Fusing Consideration, (t = 8.3 ms)	l <sup>2</sup> t	0.415	A <sup>2</sup> s
Forward Peak Gate Power, (T <sub>A</sub> = 25°C, Pulse Width $\leq$ 1.0 µs)	P <sub>GM</sub>	0.1	W
Forward Average Gate Power, ( $T_A = 25^{\circ}C$ , t = 8.3 ms)	P <sub>G(AV)</sub>	0.01	W
Forward Peak Gate Current, (T <sub>A</sub> = 25°C, Pulse Width $\leq$ 1.0 µs)	I <sub>GM</sub>	1.0	А
Reverse Peak Gate Voltage, (T <sub>A</sub> = 25°C, Pulse Width $\leq$ 1.0 µs)	V <sub>GRM</sub>	5.0	V
Operating Junction Temperature Range @ Rate $V_{\text{RRM}}$ and $V_{\text{DRM}}$	TJ	-40 to 110	°C
Storage Temperature Range	T <sub>stg</sub>	-40 to 150	°C

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

 V<sub>DRM</sub> and V<sub>RRM</sub> for all types can be applied on a continuous basis. Ratings apply for zero or negative gate voltage; however, positive gate voltage shall not be applied concurrent with negative potential on the anode. Blocking voltages shall not be tested with a constant current source such that the voltage ratings of the devices are exceeded.
See ordering information for exact device number options.

#### THERMAL CHARACTERISTICS

Characteristic		Symbo	bl	Max		Unit		
Thermal Resistance, Junction-to-Case Junction-to-Ambient		$R_{ heta JC}$ $R_{ heta JA}$		75 200	°C/W			
Lead Solder Temperature (<1/16" from case, 10 secs max)				260		°C		
ELECTRICAL CHARACTERISTICS (T <sub>C</sub> = 25°C unless otherwise noted)								
Characteristic	Syn	nbol	Min	Тур	Max	Unit		
OFF CHARACTERISTICS								
Peak Repetitive Forward or Reverse Blocking Current (Note 3) $T_{C} = 2$		I <sub>RRM</sub>	_	-	10	μΑ		
$\label{eq:VD} \begin{array}{l} T_{C} = 2 \\ (V_{D} = \text{Rated } V_{DRM} \text{ and } V_{RRM}; \ R_{GK} = 1 \ k\Omega) \\ \end{array} \qquad \qquad T_{C} = 1 \\ \end{array}$	10°C		-	-	100			

#### **ON CHARACTERISTICS**

UN UNANAUTENISTICS					
Peak Forward On–State Voltage <sup>*</sup> (I <sub>TM</sub> = 1.0 A Peak @ T <sub>A</sub> = 25°C)	V <sub>TM</sub>	-	-	1.7	V
$ \begin{array}{ll} \mbox{Gate Trigger Current (Note 4)} & T_{C} = 25^{\circ} C \\ \mbox{(V_{AK} = 7.0 Vdc, R_{L} = 100 } \Omega ) \end{array} $	I <sub>GT</sub>	-	40	200	μΑ
	Ι <sub>Η</sub>		0.5 -	5.0 10	mA
$ \begin{array}{ll} \mbox{Latch Current (Note 4)} & T_{C} = 25^{\circ} C \\ (V_{AK} = 7.0 \mbox{ V, Ig} = 200  \mu A) & T_{C} = -40^{\circ} C \end{array} $	۱ <sub>L</sub>		0.6 -	10 15	mA
$ \begin{array}{ll} \mbox{Gate Trigger Voltage (Note 4)} & T_{C} = 25^{\circ} C \\ \mbox{(V}_{AK} = 7.0 \mbox{ Vdc}, \ R_{L} = 100 \ \Omega ) & T_{C} = -40^{\circ} C \end{array} $	V <sub>GT</sub>		0.62 -	0.8 1.2	V
DYNAMIC CHARACTERISTICS		-	-	<u>e</u>	
Critical Rate of Rise of Off-State Voltage	dV/dt	20	35	-	V/μs

$(V_D = \text{Rated } V_{DRM}, \text{Exponential Waveform}, R_{GK} = 1 \text{ k}\Omega, T_J = 110^{\circ}\text{C})$	,				, pro
Critical Rate of Rise of On–State Current (I <sub>PK</sub> = 20 A; Pw = 10 µsec; diG/dt = 1 A/µsec, Igt = 20 mA)	di/dt	-	-	50	A/μs

\*Indicates Pulse Test: Pulse Width  $\leq$  1.0 ms, Duty Cycle  $\leq$  1%.

3.  $R_{GK}$  = 1000  $\Omega$  included in measurement.

4. Does not include R<sub>GK</sub> in measurement.

## Voltage Current Characteristic of SCR

+ Current

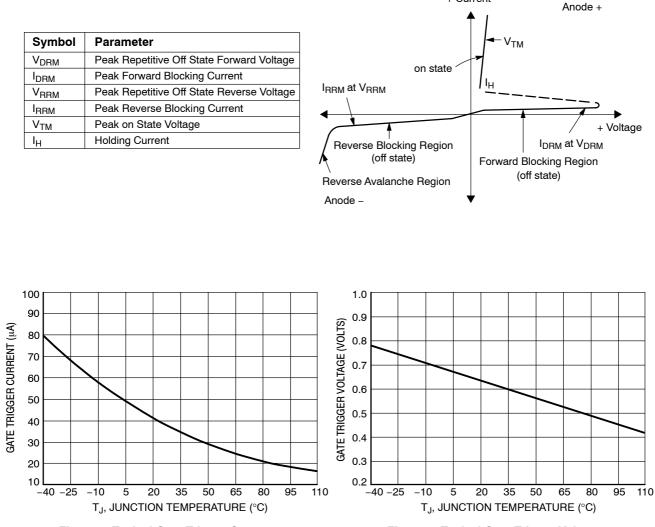
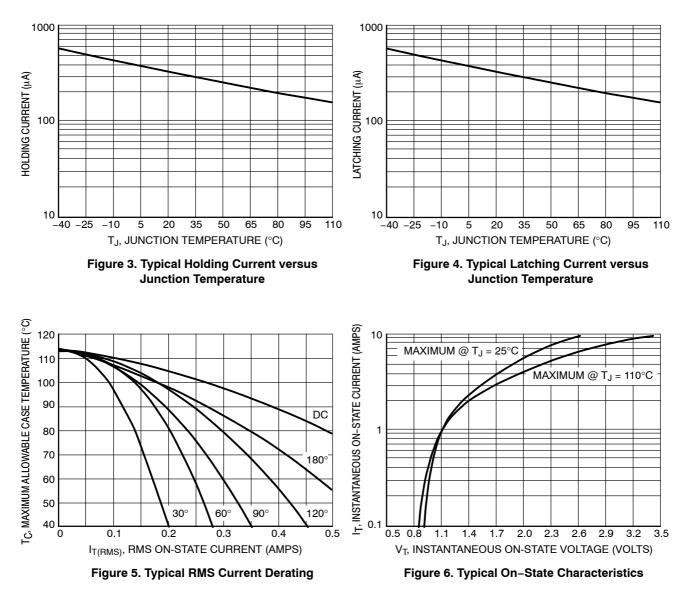


Figure 1. Typical Gate Trigger Current versus Junction Temperature

Figure 2. Typical Gate Trigger Voltage versus Junction Temperature



### **ORDERING INFORMATION**

Device	Package Code	Shipping <sup>†</sup>			
MCR100-003					
MCR100-004					
MCR100-006		5000 Units / Box			
MCR100-008					
MCR100-3RL					
MCR100-6RL	TO-92 (TO-226)	2000 / Tape & Reel			
MCR100-6RLRA					
MCR100-6RLRM		COOD / Take & Annua David			
MCR100-6ZL1		2000 / Tape & Ammo Pack			
MCR100-8RL		2000 / Tape & Reel			
MCR100-3G					
MCR100-4G		5000 H - 15 / D			
MCR100-6G		5000 Units / Box			
MCR100-8G					
MCR100-3RLG					
MCR100-6RLG	TO-92 (TO-226) (Pb-Free)	2000 / Tape & Reel			
MCR100-6RLRAG	(				
MCR100-4RLRMG					
MCR100-6RLRMG		2000 / Tape & Ammo Pack			
MCR100-6ZL1G					
MCR100-8RLG		2000 / Tape & Reel			

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

## TO-92 EIA RADIAL TAPE IN BOX OR ON REEL

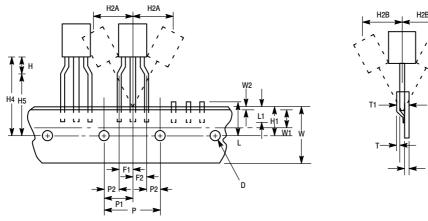


Figure 7. Device Positioning on Tape

		Specification			
		Inc	hes	Millir	neter
Symbol	Item	Min	Мах	Min	Max
D	Tape Feedhole Diameter	0.1496	0.1653	3.8	4.2
D2	Component Lead Thickness Dimension	0.015	0.020	0.38	0.51
F1, F2	Component Lead Pitch	0.0945	0.110	2.4	2.8
Н	Bottom of Component to Seating Plane	.059	.156	1.5	4.0
H1	Feedhole Location	0.3346	0.3741	8.5	9.5
H2A	Deflection Left or Right	0	0.039	0	1.0
H2B	Deflection Front or Rear	0	0.051	0	1.0
H4	Feedhole to Bottom of Component	0.7086	0.768	18	19.5
H5	Feedhole to Seating Plane	0.610	0.649	15.5	16.5
L	Defective Unit Clipped Dimension	0.3346	0.433	8.5	11
L1	Lead Wire Enclosure	0.09842		2.5	—
Р	Feedhole Pitch	0.4921	0.5079	12.5	12.9
P1	Feedhole Center to Center Lead	0.2342	0.2658	5.95	6.75
P2	First Lead Spacing Dimension	0.1397	0.1556	3.55	3.95
Т	Adhesive Tape Thickness	0.06	0.08	0.15	0.20
T1	Overall Taped Package Thickness	_	0.0567	_	1.44
T2	Carrier Strip Thickness	0.014	0.027	0.35	0.65
W	Carrier Strip Width	0.6889	0.7481	17.5	19
W1	Adhesive Tape Width	0.2165	0.2841	5.5	6.3
W2	Adhesive Tape Position	.0059	0.01968	.15	0.5

NOTES:

1. Maximum alignment deviation between leads not to be greater than 0.2 mm.

2. Defective components shall be clipped from the carrier tape such that the remaining protrusion (L) does not exceed a maximum of 11 mm.

3. Component lead to tape adhesion must meet the pull test requirements.

4. Maximum non-cumulative variation between tape feed holes shall not exceed 1 mm in 20 pitches.

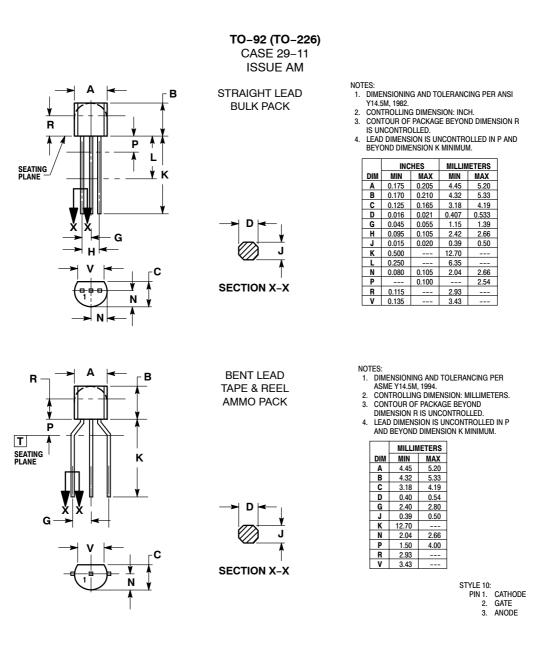
5. Hold down tape not to extend beyond the edge(s) of carrier tape and there shall be no exposure of adhesive.

6. No more than 1 consecutive missing component is permitted.

7. A tape trailer and leader, having at least three feed holes is required before the first and after the last component.

8. Splices will not interfere with the sprocket feed holes.

#### PACKAGE DIMENSIONS



ON Semiconductor and 💷 are registered trademarks of Semiconductor Components Industries, LLC (SCILLC). SCILLC reserves the right to make changes without further notice to any products herein. SCILC makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does SCILC assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. "Typical" parameters which may be provided in SCILC data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. SCILC does not convey any license under its patent rights or the rights of others. SCILC products are not designed, intended, or authorized for use a components in systems intended for surgical implant into the body, or other applications. intended to support or sustain life, or for any other application in which the failure of the SCILLC product could create a situation where personal injury or death may occur. Should Buyer purchase or use SCILLC products for any such unintended or unauthorized application, Buyer shall indemnify and hold SCILLC and its officers, employees, subsidiaries, affiliates, and distributors harmless against all claims, costs, damages, and expenses, and reasonable attorney fees arising out of, directly or indirectly, any claim of personal injury or death associated with such unintended or unauthorized use, even if such claim alleges that SCILLC was negligent regarding the design or manufacture of the part. SCILLC is an Equal Opportunity/Affirmative Action Employer. This literature is subject to all applicable copyright laws and is not for resale in any manner.

#### PUBLICATION ORDERING INFORMATION

#### LITERATURE FULFILLMENT:

Literature Distribution Center for ON Semiconductor P.O. Box 5163, Denver, Colorado 80217 USA Phone: 303-675-2175 or 800-344-3860 Toll Free USA/Canada Fax: 303-675-2176 or 800-344-3867 Toll Free USA/Canada Email: orderlit@onsemi.com

N. American Technical Support: 800-282-9855 Toll Free USA/Canada Europe, Middle East and Africa Technical Support:

#### Phone: 421 33 790 2910 Japan Customer Focus Center

ON Semiconductor Website: www.onsemi.com

Order Literature: http://www.onsemi.com/orderlit For additional information, please contact your local

Sales Representative

Phone: 81-3-5773-3850